

MBL1600E17F

Silicon N-channel IGBT 1700V F version

FEATURES

- * Soft switching behavior & low conduction loss:
Soft low-injection punch-through with trench gate IGBT.
- * Low driving power:
Low input capacitance with advanced trench gate.
- * Low noise recovery: Ultra soft fast recovery diode.

ABSOLUTE MAXIMUM RATINGS (T_C=25°C)

Item	Symbol	Unit	MBL1600E17F
Collector Emitter Voltage	V _{CES}	V	1,700
Gate Emitter Voltage	V _{GES}	V	±20
Collector Current	DC	A	1,600
	1ms		3,200
Forward Current (Free wheel Diode)	DC	A	1,200
	1ms		2,400
Forward Current (Chopper Diode)	DC	A	1,200
	1ms		2,400
Operating Junction Temperature	T _{vj op}	°C	-50 ~ +150
Maximum Junction Temperature (3)	T _{vj max}	°C	175
Storage Temperature	T _{stg}	°C	-55 ~ +125
Isolation Voltage	V _{ISO}	V _{RMS}	4,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	N·m	2/15 (1)
	Mounting (M6)		6 (2)

Notes: (1) Recommended Value $1.8 \pm 0.2/15^{+0}/_{-3} \text{N} \cdot \text{m}$ (2) Recommended Value $5.5 \pm 0.5 \text{N} \cdot \text{m}$
 (3) Regarding the definition of T_{vj max} for each operation mode, please refer to LD-ES-130737.

ELECTRICAL CHARACTERISTICS

1) IGBT+FWD

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	I _{CES}	mA	-	-	5	V _{CE} =1,700V, V _{GE} =0V, T _{vj} =25°C
			-	20	80	V _{CE} =1,700V, V _{GE} =0V, T _{vj} =150°C
Gate Emitter Leakage Current	I _{GES}	nA	-500	-	+500	V _{GE} =±20V, V _{CE} =0V, T _{vj} =25°C
Collector Emitter Saturation Voltage	V _{CEsat}	V	-	2.0	-	I _C =1,600A, V _{GE} =15V, T _{vj} =25°C
			2.0	2.4	2.8	I _C =1,600A, V _{GE} =15V, T _{vj} =150°C
Gate Emitter Threshold Voltage	V _{GE(th)}	V	4.1	5.5	7.1	V _{CE} =10V, I _C =160mA, T _{vj} =25°C
Input Capacitance	C _{ies}	nF	-	87	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _{vj} =25°C
Internal Gate Resistance	R _{G(int)}	Ω	-	2.3	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _{vj} =25°C
Turn On Delay Time	t _{d(on)}	μs	-	0.6	1.2	V _{CC} =900V, I _C =1,600A L _S =120nH R _{G(on/off)} =3.9/3.9Ω (4) V _{GE} =±15V, T _{vj} =150°C
Rise Time	t _r		-	0.4	0.8	
Turn Off Delay Time	t _{d(off)}		-	1.8	3.6	
Fall Time	t _f		-	1.4	2.8	
Turn On Loss	E _{on}	J/P	-	0.5	-	I _F =1,200A, V _{GE} =0V, T _{vj} =25°C Measured at auxiliary terminals
Turn Off Loss	E _{off}	J/P	-	1.4	-	
Forward Voltage Drop	V _F	V	-	2.0	-	I _F =1,200A, V _{GE} =0V, T _{vj} =150°C Measured at auxiliary terminals
			-	2.3	-	I _F =1,200A, V _{GE} =0V, T _{vj} =150°C Measured at auxiliary terminals
Thermal Impedance	IGBT	R _{th(j-c)}	K/W	-	0.015	Junction to case
	FWD	R _{th(j-c)}			0.033	
Contact Thermal Impedance		R _{th(c-f)}	K/W	0.008	-	Case to fin (λgrease=1W/(m·K), heat-sink flatness ≤50μm)

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2) Chopper Diode

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Repetitive Reverse Current	I_{RRM}	mA	-	-	2.5	$V_R=1,700V$, $T_{vj}=25^{\circ}C$
			-	10	40	$V_R=1,700V$, $T_{vj}=150^{\circ}C$
Forward Voltage Drop (Between main terminals)	V_F	V	-	2.1	-	$I_F=1,200A$, $T_{vj}=25^{\circ}C$ Measured at main terminals
			-	2.4	-	$I_F=1,200A$, $T_{vj}=150^{\circ}C$ Measured at main terminals
Reverse Recovery Time	t_{rr}	μs	-	0.6	-	$V_{CC}=900V$, $I_F=1,200A$
Reverse Recovery Loss	E_{rr}	J/P	-	0.5	-	$L_S=120nH$, $R_{G(on)}=3.9\Omega$ (4) $V_{GE}=\pm 15V$, $T_{vj}=150^{\circ}C$
Thermal Impedance	$R_{th(j-c)}$	K/W	-	-	0.033	Junction to case
Contact Thermal Impedance	$R_{th(c-f)}$	K/W	-	0.016	-	Case to fin (at Chopper Diode part)

Notes: (4) L_S and R_G are the test condition's values for evaluation of the switching times, not recommended value.

Please, determine the suitable R_G value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

* Please contact our representatives at order.

* For improvement, specifications are subject to change without notice.

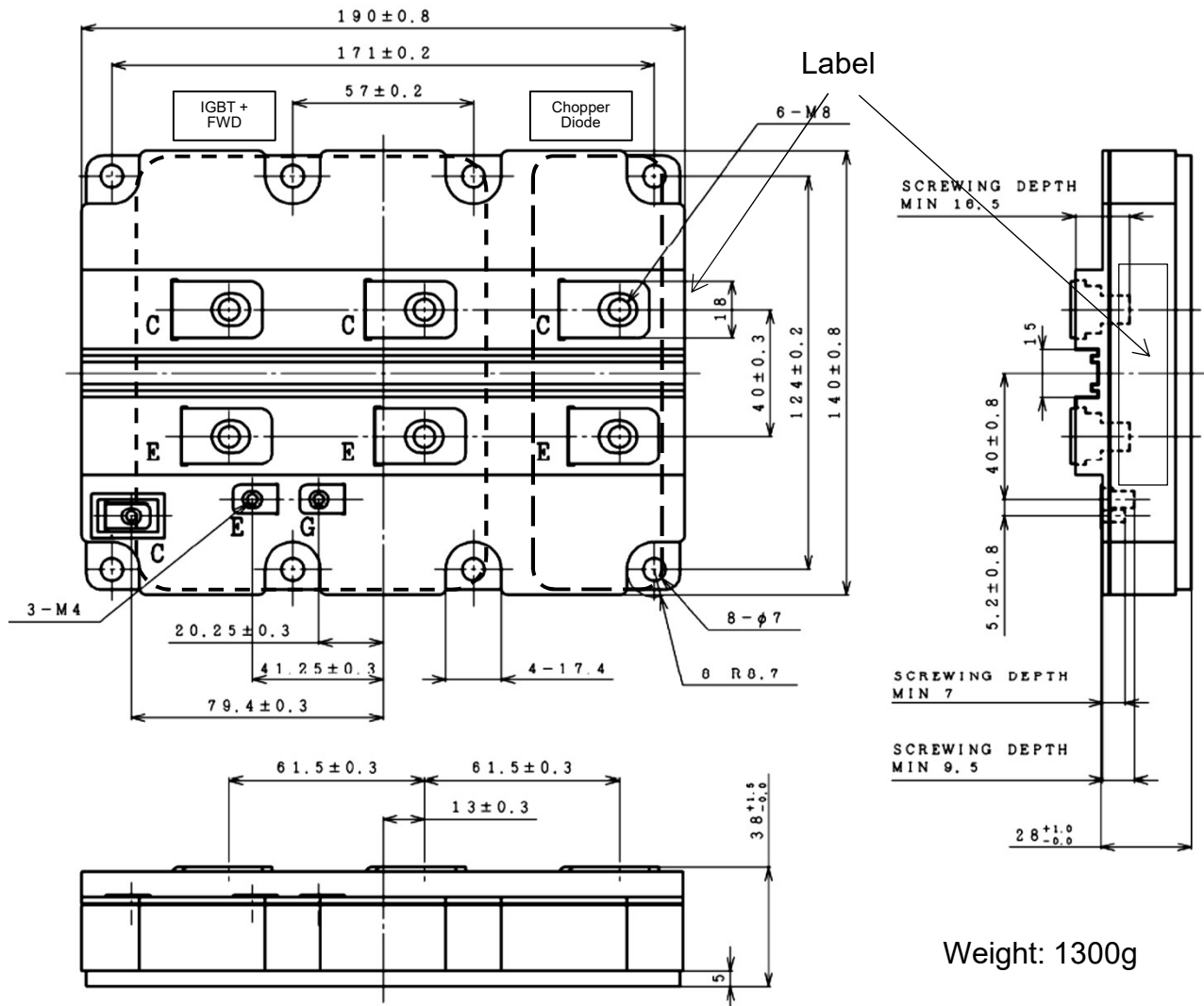
* For actual application, please confirm this spec sheet is the newest revision.

* ELECTRICAL CHARACTERISTIC items shown in above table are according to IEC 60747-2 and IEC 60747-9.

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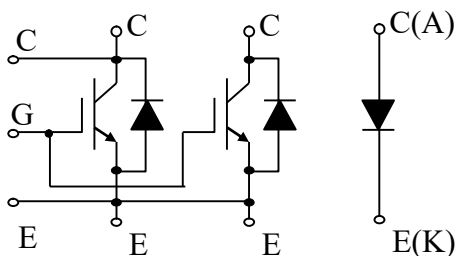
OUTLINE DRAWING

Unit in mm

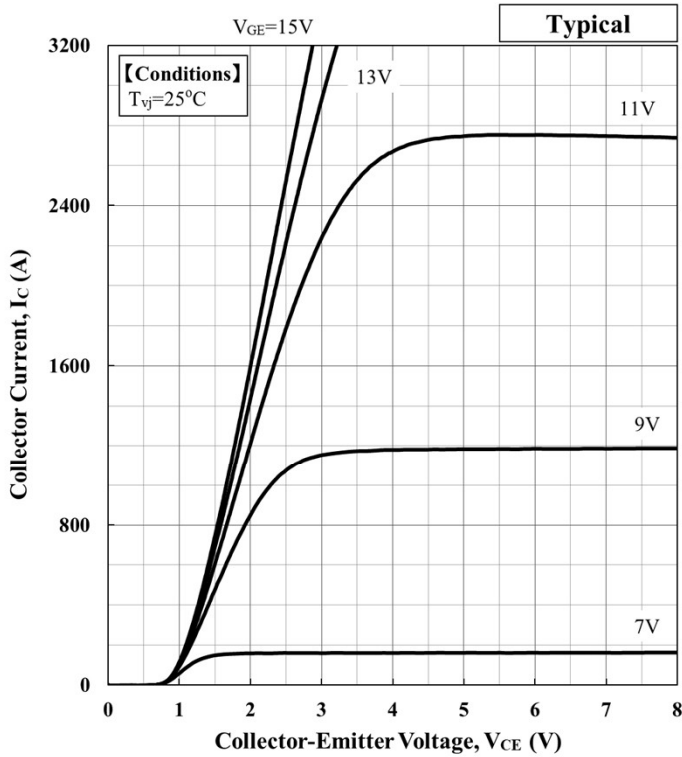


Weight: 1300g

CIRCUIT DIAGRAM



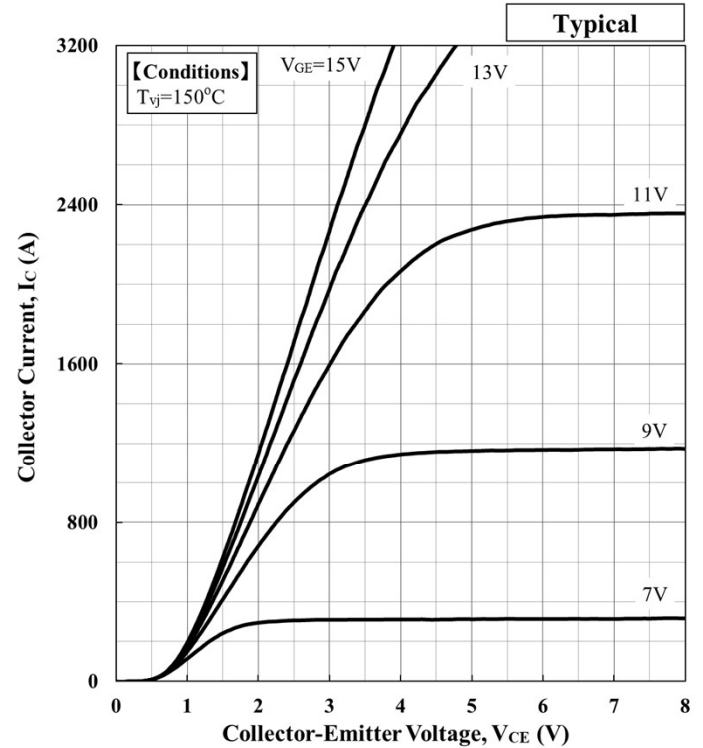
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$$V_{CE(sat)}[V] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	$V_{GE}[V]$	a_3	a_2	a_1	a_0
25	15	2.10.E-11	-1.40.E-07	8.38.E-04	9.41.E-01

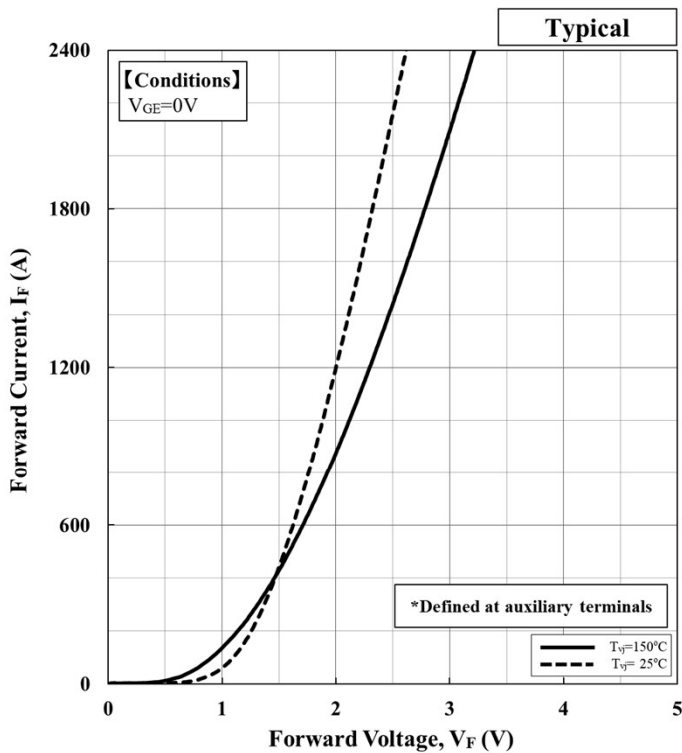
Collector Current vs. Collector Emitter Voltage



$$V_{CE(sat)}[V] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	$V_{GE}[V]$	a_3	a_2	a_1	a_0
150	15	4.11.E-11	-2.26.E-07	1.28.E-03	7.65.E-01

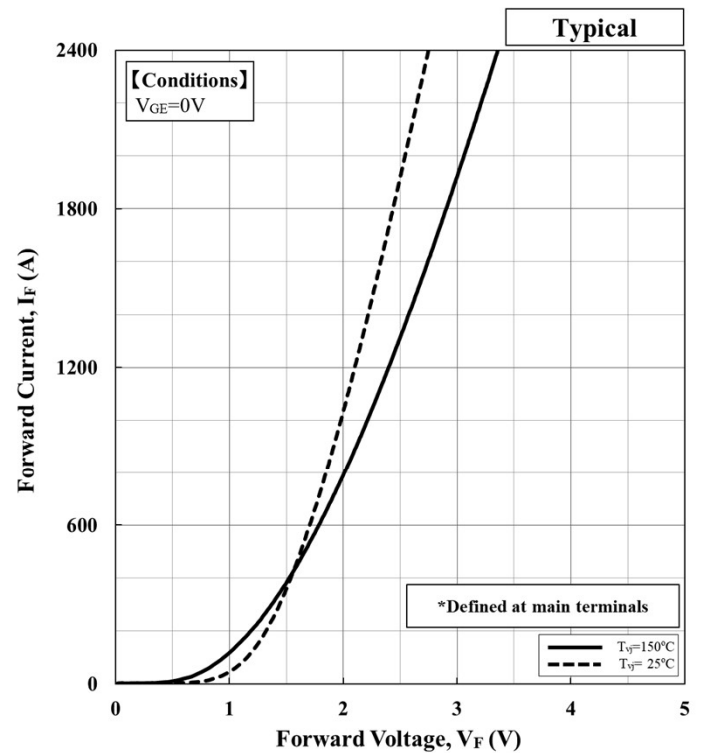
Collector Current vs. Collector Emitter Voltage



$$V_F[V] = a_3 \cdot |I_F|^3 + a_2 \cdot |I_F|^2 + a_1 \cdot |I_F| + a_0$$

Temp.[°C]	a_3	a_2	a_1	a_0
25	6.88.E-11	-3.70.E-07	1.15.E-03	1.04.E+00
150	1.03.E-10	-5.77.E-07	1.80.E-03	8.06.E-01

Forward Voltage of free-wheeling diode

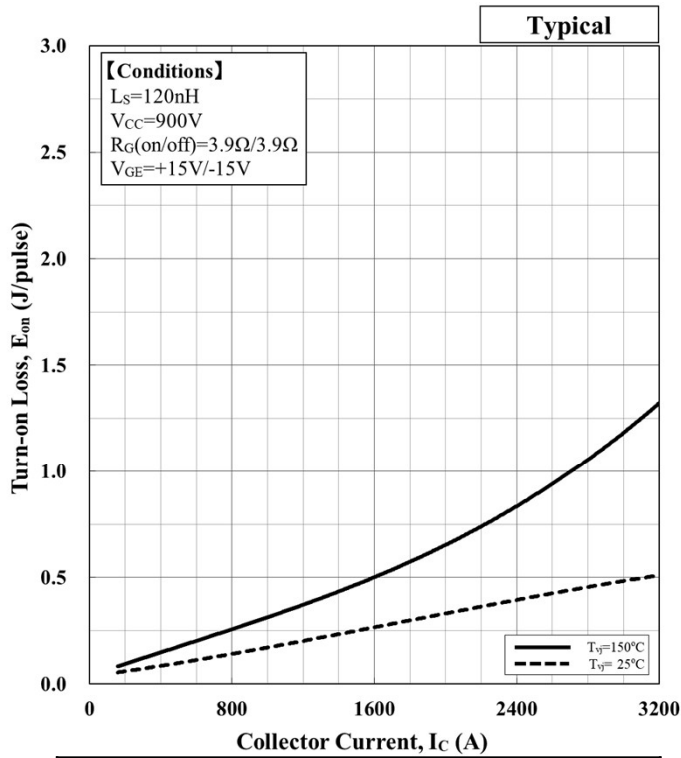


$$V_F[V] = a_3 \cdot |I_F|^3 + a_2 \cdot |I_F|^2 + a_1 \cdot |I_F| + a_0$$

Temp.[°C]	a_3	a_2	a_1	a_0
25	7.22.E-11	-3.88.E-07	1.21.E-03	1.10.E+00
150	1.08.E-10	-6.02.E-07	1.87.E-03	8.41.E-01

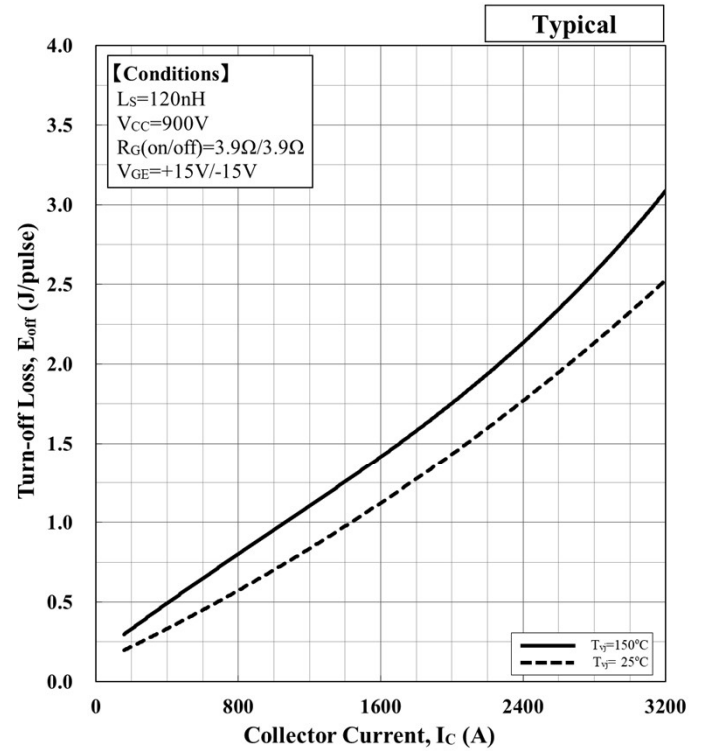
Forward Voltage of Chopper diode

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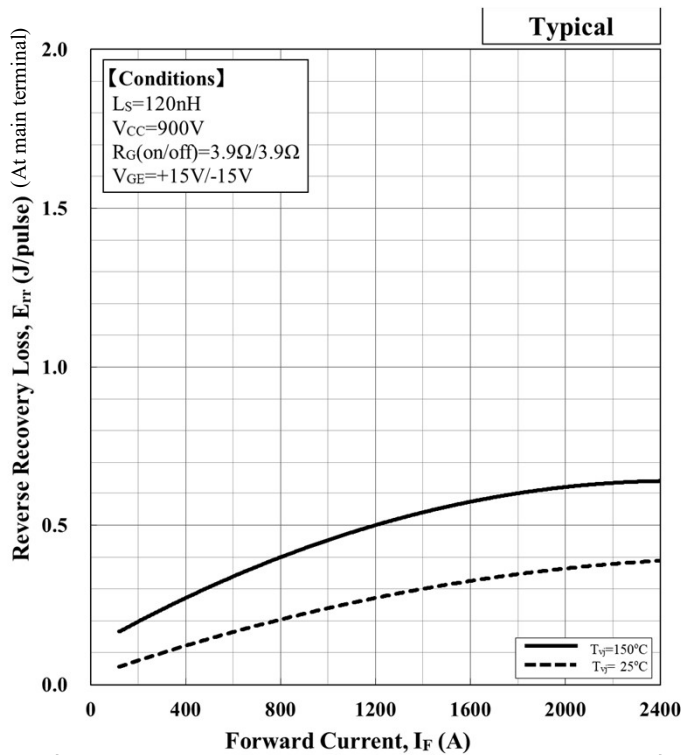
$E [J] = a_3 \cdot I_c ^3 + a_2 \cdot I_c ^2 + a_1 \cdot I_c + a_0$				
Temp.[°C]	a_3	a_2	a_1	a_0
25	-5.40E-12	2.86E-08	1.12E-04	3.64E-02
150	2.10E-11	-3.07E-08	2.85E-04	3.82E-02

Turn-on loss vs. Collector current



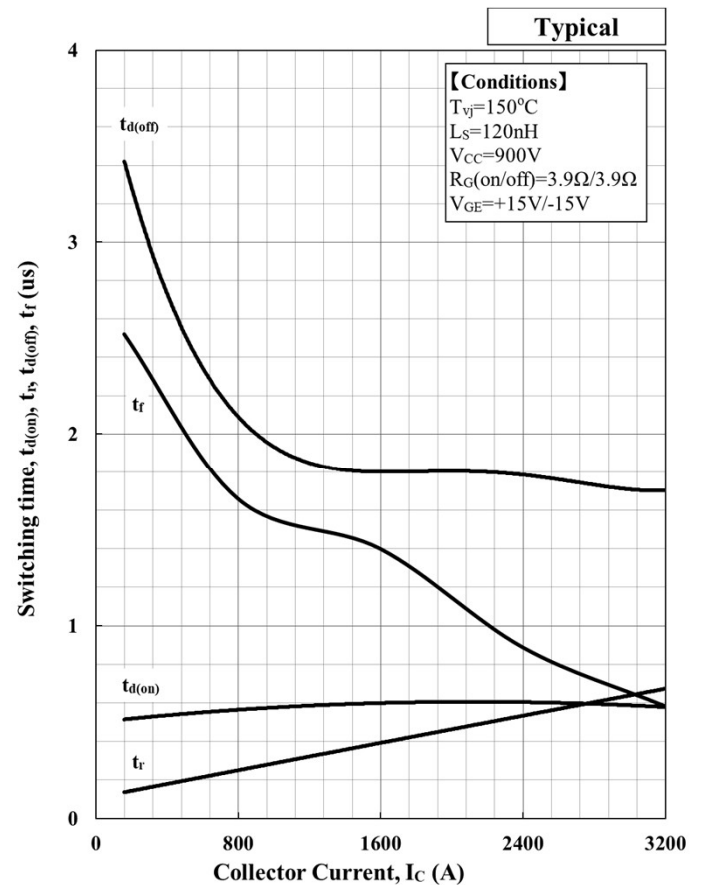
$E [J] = a_3 \cdot I_c ^3 + a_2 \cdot I_c ^2 + a_1 \cdot I_c + a_0$				
Temp.[°C]	a_3	a_2	a_1	a_0
25	3.08E-12	6.24E-08	5.23E-04	1.14E-01
150	4.17E-11	-1.19E-07	8.67E-04	1.63E-01

Turn-off loss vs. Collector current



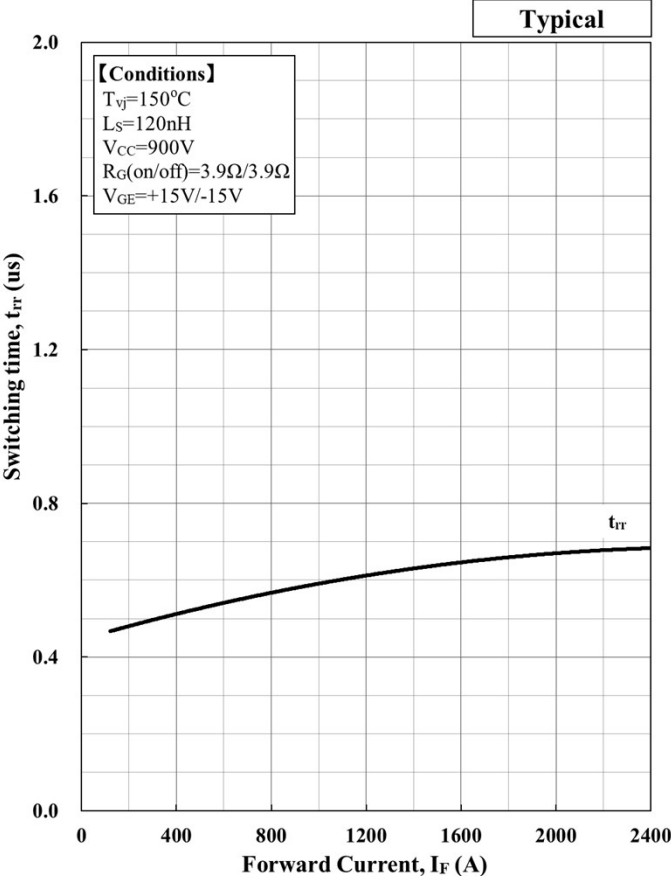
$E [J] = a_3 \cdot I_F ^3 + a_2 \cdot I_F ^2 + a_1 \cdot I_F + a_0$				
Temp.[°C]	a_3	a_2	a_1	a_0
25	-	-4.50E-08	2.59E-04	2.57E-02
150	-	-8.51E-08	4.22E-04	1.17E-01

Recovery loss vs. Forward current of Chopper Diode



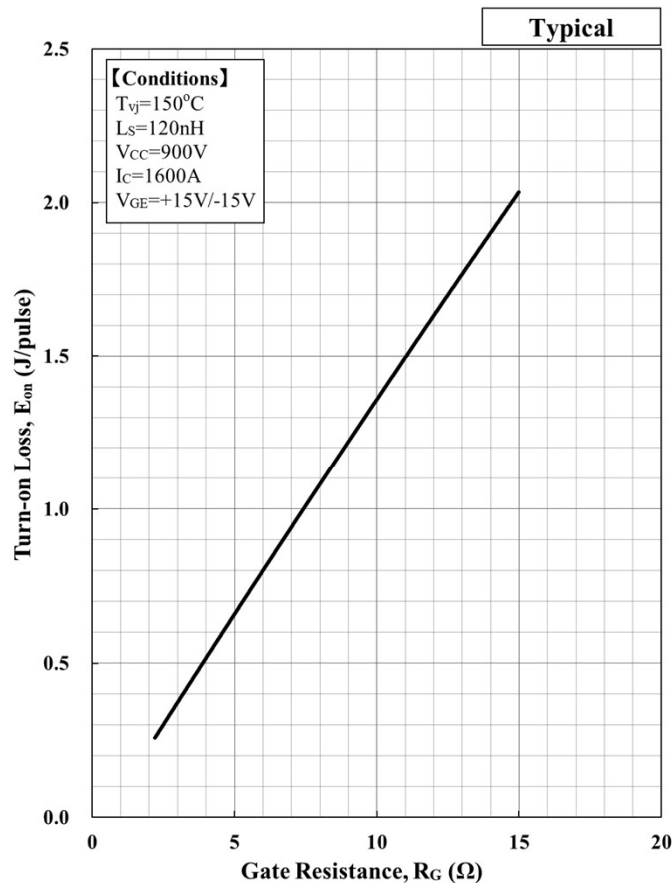
Switching time vs. Collector Current

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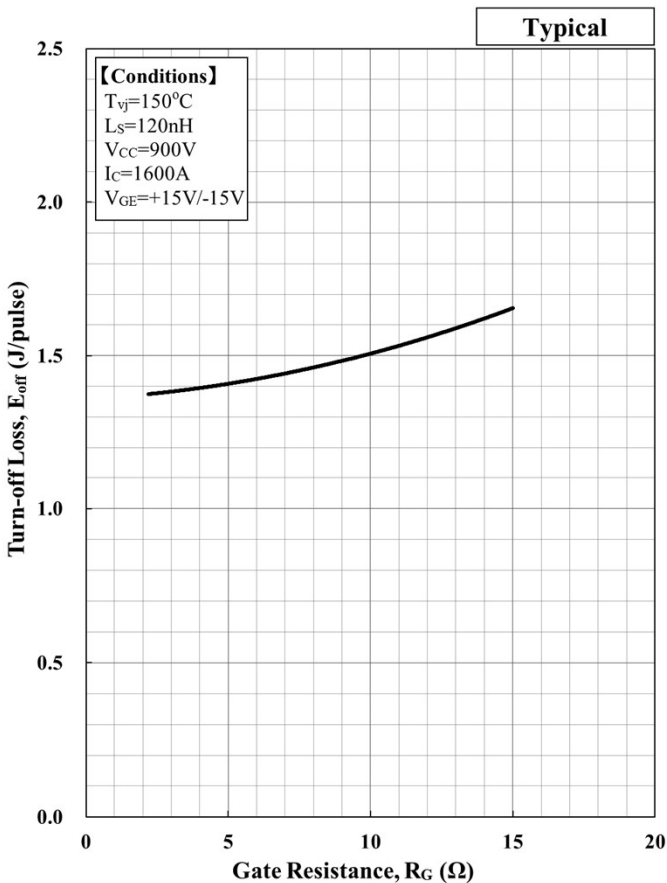


Switching time vs. Forward current of Chopper diode

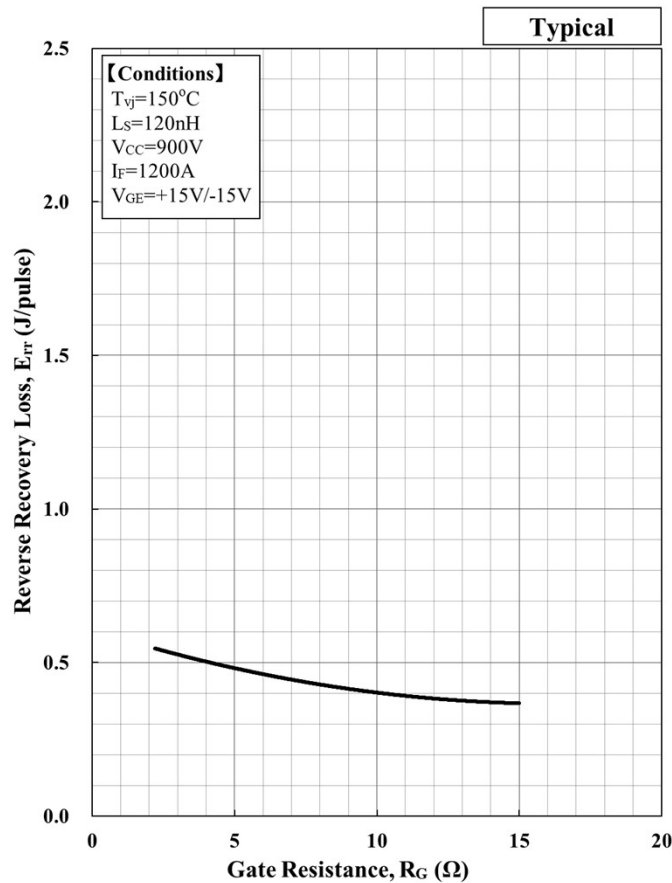
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Turn-on loss vs. Gate Resistance

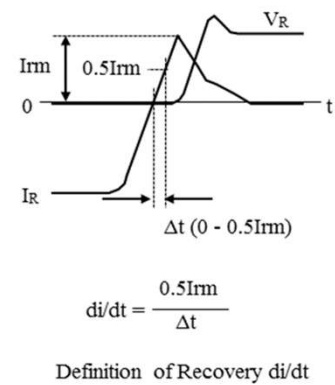
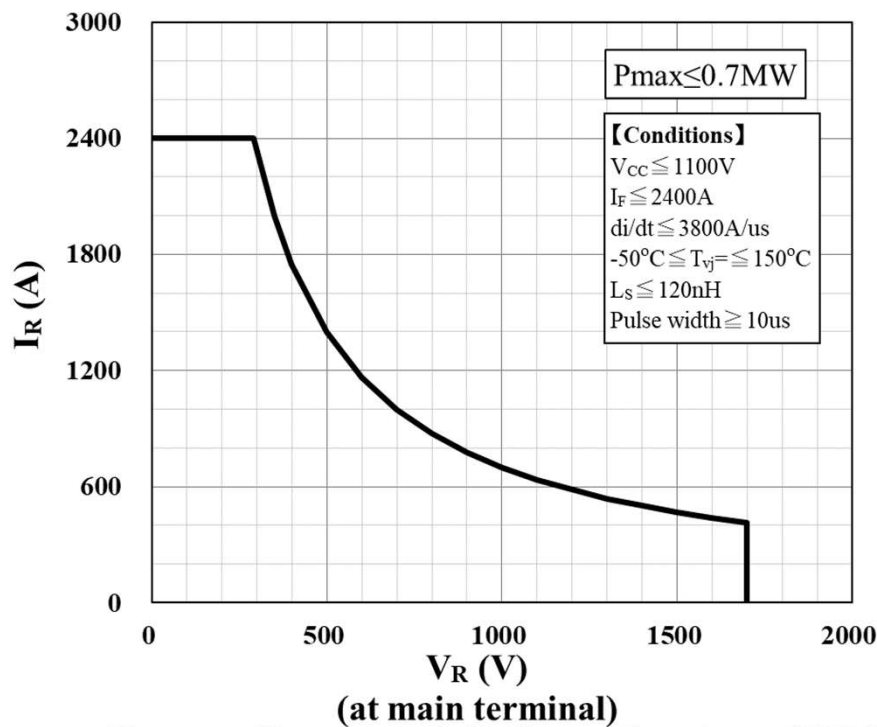
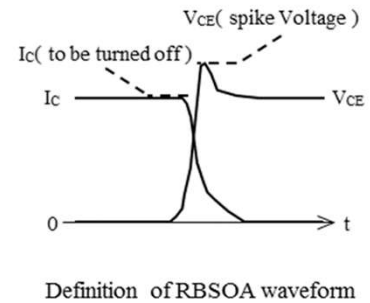
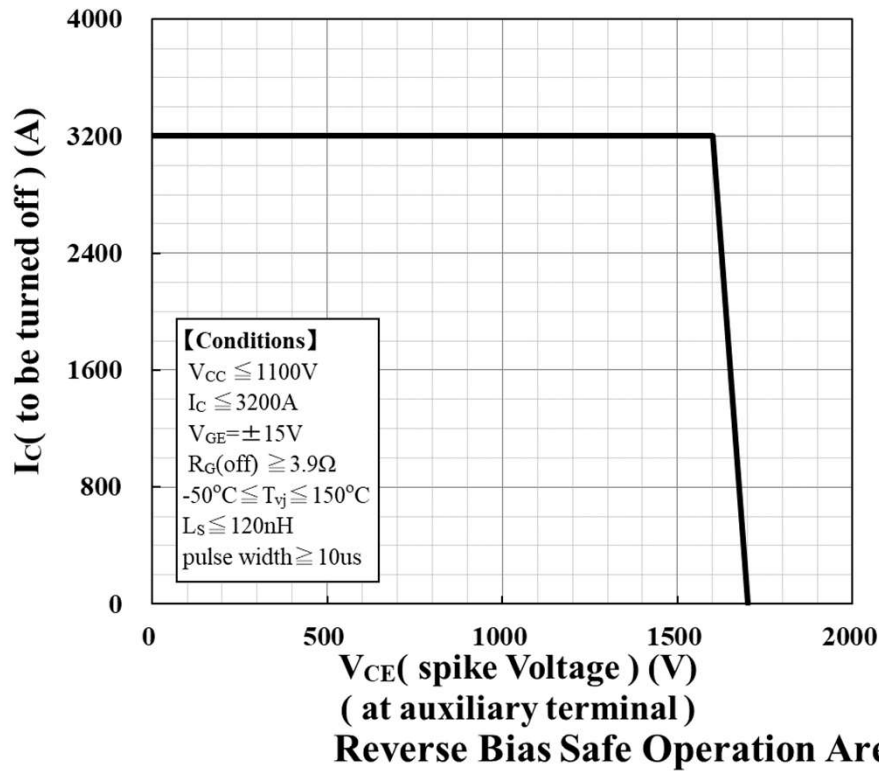


Turn-off loss vs. Gate Resistance

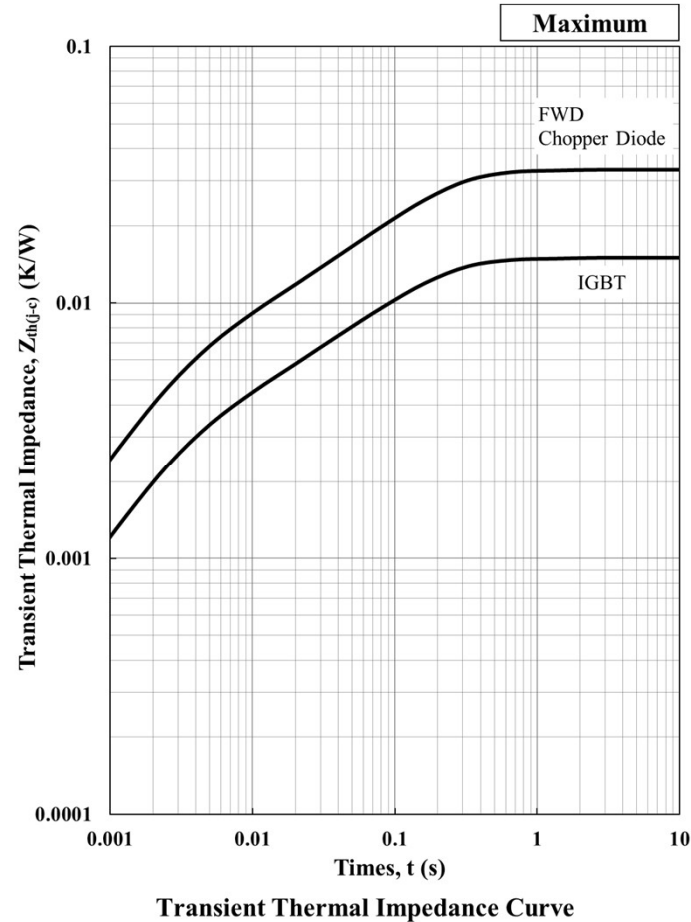
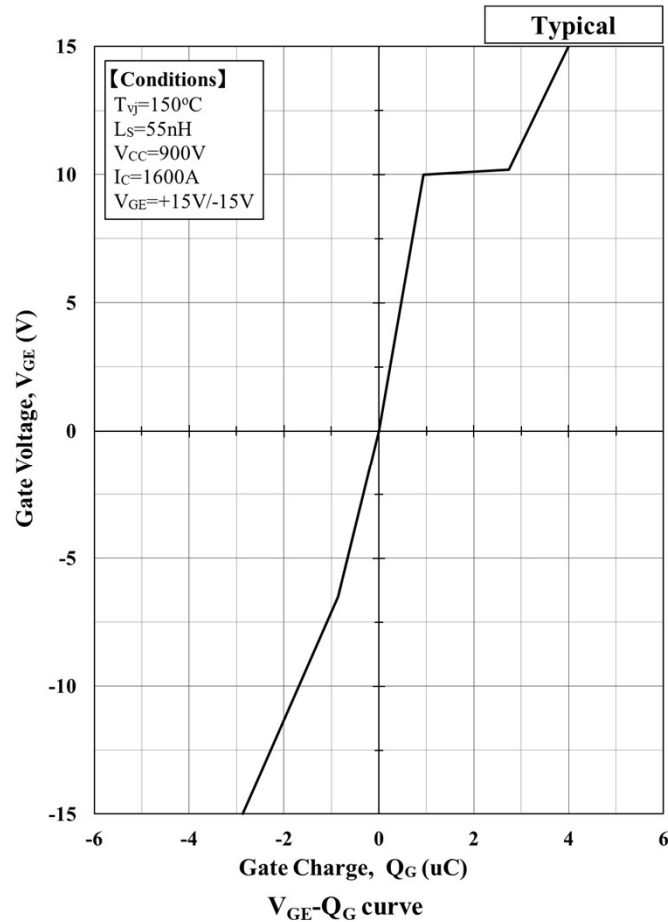


Reverse Recovery loss vs. Gate Resistance of Chopper Diode

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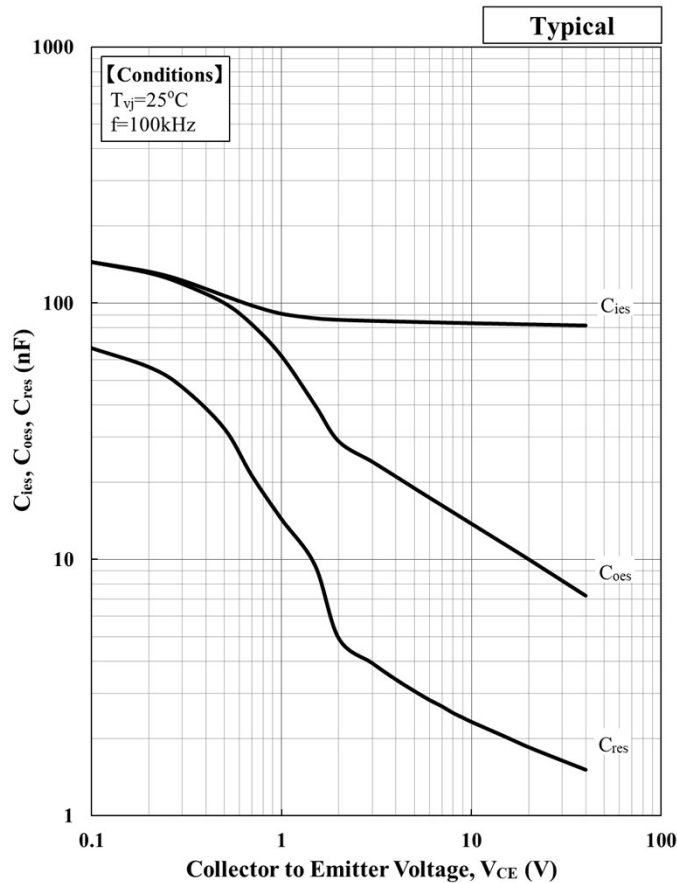
Foster model lumped circuit constant

n	1	2	3	4	Unit
R th, IGBT [n]	8.97E-03	2.93E-03	2.70E-03	3.97E-04	[K/W]
C th, IGBT [n]	1.68E+01	8.80E+00	1.15E+00	1.41E+00	[J/K]
R th, Diode [n]	2.15E-02	5.30E-03	5.43E-03	8.00E-04	[K/W]
C th, Diode [n]	7.00E+00	4.87E+00	5.69E-01	7.01E-01	[J/K]

Cauer model lumped circuit constant

n	1	2	3	4	Unit
R th, IGBT [n]	1.99E-03	2.42E-03	5.35E-03	5.25E-03	[K/W]
C th, IGBT [n]	5.71E-01	8.02E-01	5.73E+00	1.91E+01	[J/K]
R th, Diode [n]	4.00E-03	4.88E-03	1.20E-02	1.21E-02	[K/W]
C th, Diode [n]	2.83E-01	3.98E-01	2.79E+00	7.53E+00	[J/K]

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Capacitance vs. Collector to Emitter Voltage

Material declaration

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

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Minebea POWER SEMICONDUCTORS

Notices

1. Since mishandling of semiconductor devices may cause malfunctions, please be sure to read "Precautions for Safe Use and Notices" in the individual brochure before use.
2. When designing an electronic circuit using semiconductor devices, please do not exceed the absolute maximum rating specified for the device under any external fluctuations. And for pulse applications, please also do not exceed the "Safe Operating Area (SOA)".
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5. A semi-processed article is done now using solder which contains lead inside the semiconductor devices. There is possibility of the regulation substance depend on the applied models, so please check before using.
6. This specification is a material for component selection, which describes specifications of power semiconductor devices (hereinafter referred to as products), characteristic charts, and external dimension drawings.
7. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact with Minebea power semiconductor sales department for the latest version of this data sheets.
8. For handling other than described in this manual, follow the handling instructions (IGBT-HI-00002).

■ For inquiries relating to the products, please contact nearest representatives that is located "Inquiry" portion on the top page of a home page.

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